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Application/Control No.	Applicant(s)/Patent under Reexamination
09/682,504	HANEDA, JUN
Examiner	Art Unit
Habte Mered	2662

SEARCHED				
Class	Subclass	Date	Examiner	
370	238,389(li mited text search)	9/2/2005	НМ	
370	254-258	9/2/2005	НМ	
709	238-244	9/2/2005	НМ	
709	220-224	9/2/2005	НМ	
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INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
	<u> </u>		

SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
Searched Palm Inventor DB	9/2/2005	нм
Searched IEEE	9/2/2005	нм
Searched East DB: USPG- PUB;USPAT;EPO; and JPO	9/2/2005	нм
Consulted with John Pezzlo (received search classes)	9/2/2005	нм
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